

ON Semiconductor®

FDB075N15A-F085

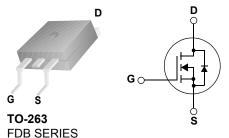
N-Channel Power Trench® MOSFET 150V, 110A, $7.5m\Omega$

Features

- Typ $r_{DS(on)}$ = 5.5m Ω at V_{GS} = 10V, I_D = 80A
- Typ $Q_{q(tot)}$ = 80nC at V_{GS} = 10V, I_D = 80A
- UIS Capability
- RoHS Compliant
- Qualified to AEC Q101

Applications

- Automotive Engine Control
- Powertrain Management
- Solenoid and Motor Drivers
- Integrated Starter/alternator
- Primary Switch for 12V Systems





MOSFET Maximum Ratings T_J = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain to Source Voltage		150	V
V_{GS}	Gate to Source Voltage		±20	V
	Drain Current - Continuous (V_{GS} =10) (Note 1) T_C = 25°C		110	Α
ID	Pulsed Drain Current	T _C = 25°C	See Figure4	
E _{AS}	Single Pulse Avalanche Energy	(Note 2)	502	mJ
D	Power Dissipation		333	W
P_{D}	Derate above 25°C		2.22	W/°C
T _J , T _{STG}	Operating and Storage Temperature		-55 to + 175	°C
$R_{\theta JC}$	Thermal Resistance Junction to Case		0.45	°C/W
$R_{\theta JA}$	Maximum Thermal Resistance Junction to Ambient	(Note 3)	43	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB075N15A	FDB075N15A-F085	D2-PAK(TO-263)	330mm	24mm	800 units

- 1: Current is limited by bondwire configuration.
 2: Starting $T_J = 25^{\circ}C$, L = 0.24mH, $I_{AS} = 64$ A, $V_{DD} = 100$ V during inductor charging and $V_{DD} = 0$ V during time in avalanche
 3: $R_{\theta,JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2oz copper.

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Cha	Off Characteristics						
Bynss	Drain to Source Breakdown Voltage	I _D = 250μA, V _{GS} = 0V	150	_	-	V	

B _{VDSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		150	-	-	V
1	Drain to Source Leakage Current	V _{DS} =150V,	$T_J = 25^{\circ}C$	-	-	1	μΑ
IDSS	Diam to Source Leakage Current	$V_{GS} = 0V$	$T_J = 175^{\circ}C(Note 4)$	-	-	1	mA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V$		-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		2.0	3.0	4.0	V
r _{DS(on)} Dra	Drain to Source On Resistance	I _D = 80A,	$T_{J} = 25^{\circ}C$	-	5.5	7.5	mΩ
		V _{GS} = 10V	$T_J = 175^{\circ}C(Note 4)$	-	14.2	20	mΩ

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 75V, V _{GS} = 0V, f = 1MHz		-	5595	-	pF
C _{oss}	Output Capacitance			-	513	-	pF
C _{rss}	Reverse Transfer Capacitance			-	16	-	pF
R_g	Gate Resistance	f = 1MHz		-	2.4	-	Ω
$Q_{g(ToT)}$	Total Gate Charge at 10V	$V_{GS} = 0$ to 10V	V _{DD} = 75V	-	80	95	nC
$Q_{g(th)}$	Threshold Gate Charge	$V_{GS} = 0$ to 2V	I _D = 80A	-	11	13	nC
Q_{gs}	Gate to Source Gate Charge		_	-	26.5	-	nC
Q_{gd}	Gate to Drain "Miller" Charge			-	14	-	nC

Switching Characteristics

t _{on}	Turn-On Time	V_{DD} = 75V, I_{D} = 80A, V_{GS} = 10V, R_{GEN} = 6Ω	-	-	100	ns
t _{d(on)}	Turn-On Delay Time		1	33	-	ns
t _r	Rise Time		-	46	-	ns
t _{d(off)}	Turn-Off Delay Time		-	76	-	ns
t _f	Fall Time		-	25	-	ns
t _{off}	Turn-Off Time		-	-	138	ns

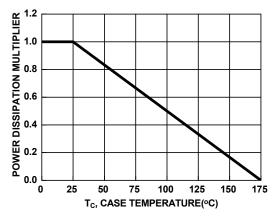
Drain-Source Diode Characteristics

V	V_{SD} Source to Drain Diode Voltage $ \frac{I_{SD} = 80A, V_{GS} = 0V}{I_{SD} = 40A, V_{GS} = 0V} $	I _{SD} = 80A, V _{GS} = 0V	-	-	1.25	V
V SD		I_{SD} = 40A, V_{GS} = 0V	-	-	1.2	V
T _{rr}	Reverse Recovery Time	$I_F = 80A$, $dI_{SD}/dt = 100A/\mu s$,	-	118	132	ns
Q _{rr}	Reverse Recovery Charge	V _{DD} =120V	-	341	494	nC

Notes

^{4:} The maximum value is specified by design at T_J = 175°C. Product is not tested to this condition in production.

Typical Characteristics



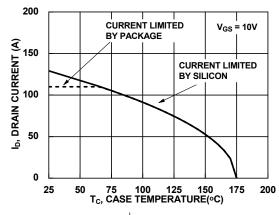


Figure 1. Normalized Power Dissipation vs Case Temperature

Figure 2. Maximum Continuous Drain Current vs Case Temperature

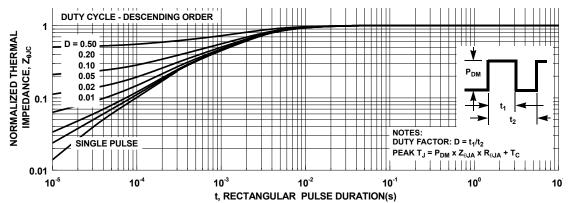


Figure 3. Normalized Maximum Transient Thermal Impedance

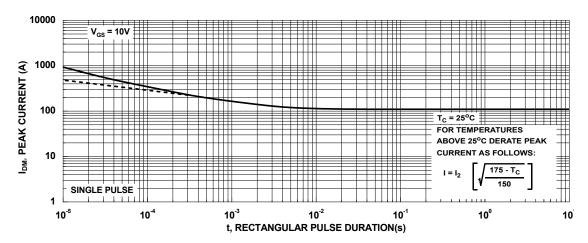


Figure 4. Peak Current Capability

Typical Characteristics

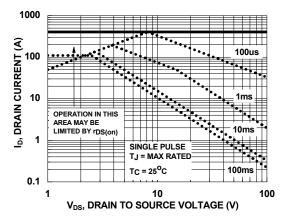
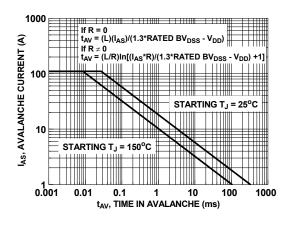


Figure 5. Forward Bias Safe Operating Area



200
PULSE DURATION = $80\mu s$ DUTY CYCLE = 0.5% MAX $V_{DD} = 5V$ $T_{J} = 175^{\circ}C$ $T_{J} = 25^{\circ}C$ $T_{J} = -55^{\circ}C$ $V_{GS}, GATE TO SOURCE VOLTAGE (V)$

Figure 7. Transfer Characteristics

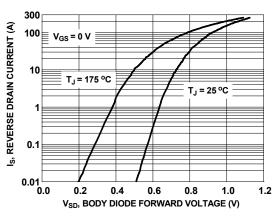


Figure 8. Forward Diode Characteristics

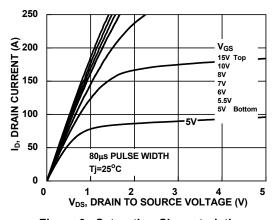


Figure 9. Saturation Characteristics

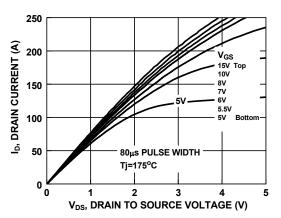


Figure 10. Saturation Characteristics

Typical Characteristics

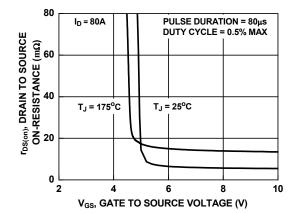


Figure 11. Rdson vs Gate Voltage

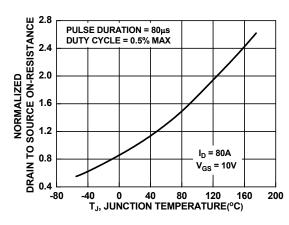


Figure 12. Normalized Rdson vs Junction Temperature

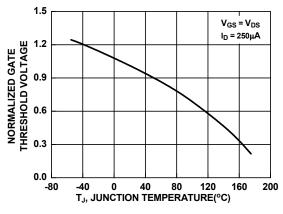


Figure 13. Normalized Gate Threshold Voltage vs
Temperature

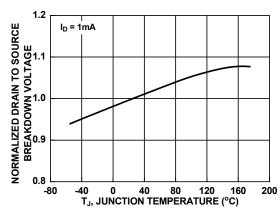


Figure 14. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

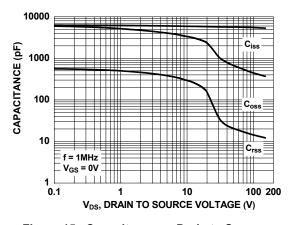


Figure 15. Capacitance vs Drain to Source Voltage

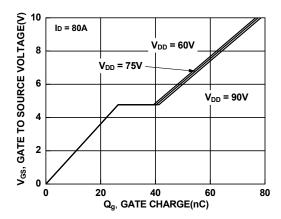


Figure 16. Gate Charge vs Gate to Source Voltage

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